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Phase assembly and electrical conductivity of spark plasma 3 sintered CeO₂-ZrO₂ ceramics 4

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10 Abstract $Ce_x Zr_{1-x}O_2$ (x = 0.10, 0.16 and 0.33) nanocrystalline powders were obtained by a two-step synthesis 11 technique and sintered by spark plasma sintering (SPS). As 12 consequence of the reduction of Ce^{4+} to Ce^{3+} species by 13 14 carbon in the graphite environment in SPS, phase assem-15 blies including tetragonal, monoclinic and pyrochlore 16 phases were generated in the ceramics during the sintering 17 process. The electrical conductivity was highly dependent 18 on phase assembly and atmosphere (N_2 , H_2 and O_2). A 19 significant decrease in the activation energy was noticed in 20 the ceramics with high pyrochlore content when measuring 21 the conductivity in H₂ atmosphere, consequence of the 22 strong reduction promoted in these ceramics during the 23 measurement. Equal conduction behavior with similar 24 activation energy was observed in all the ceramics when 26 measuring in O_2 atmosphere.

Keywords CeO_2 -ZrO₂ · Spark plasma sintering 27

28 Pyrochlore · Electrical conductivity

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Introduction

CeO₂-ZrO₂-based materials have been widely investigated 30 due to their great potential for different applications, such 31 as gas sensors, solid oxide fuel cells (SOFC) or catalytic 32 materials [1-4]. 33

This system has been shown to be a mixed conductor 34 unlike most stabilized zirconias. Whereas the latter are 35 usually pure ionic conductors, the former can exhibit large 36 electronic contributions at moderate temperatures and 37 oxygen activities [5-8]. The defect structure of CeO₂-ZrO₂ 38 has been described by different authors [5, 7-9] and can be 39 summarized as follows. Due to charge neutrality consid-40 erations, a Ce^{4+} ion substituting a Zr^{4+} cannot affect any 41 additional creation of oxygen vacancies beyond the inher-42 ent defect concentration level. However, the presence of 43 Ce^{4+} ions on Zr^{4+} sites affects the point defect equilibria 44 involving oxygen vacancies, as the formation of oxygen 45 vacancies might be favored by the large size difference of 46 the two cations $(r_i(Zr^{4+}) = 0.72 \text{ Å}; r_i(Ce^{4+}) = 0.87 \text{ Å}, \text{ for})$ 47 sixfold coordination) [5, 6, 9, 10]. The second aspect is that 48 Ce⁴⁺ ion is easily reduced to Ce³⁺ under suitably low 49 oxygen partial pressures $(10^{-11} \text{ to } 10^{-19} \text{ atm})$ [11, 12]; 50 therefore, charged oxygen vacancies are produced. These 51 vacancies are coupled to free electrons localized on Ce³⁺ 52 substitutional defects, giving rise to electronic conductivity 53 through electron hopping between cerium ions [5, 7], 54 55 which is strongly dependent on the ceria content [5].

The mixed conduction makes this system an interesting 56 material for application as SOFC anode [1], and correlation 57 58 between electrical and structural properties of the ceriazirconia system has been approached in recent studies [7, 59 13–16]. Boaro et al. [16] have carried out a complete study 60 of the effects of redox history on structural, chemical and 61 electrical properties of $Ce_x Zr_{1-x}O_2$ (x = 0.20, 0.50 and 62

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63 0.80) solid solution in order to explore the suitable oper-64 ational conditions for an optimization of their use as 65 electroactive components for SOFC anodes.

66 Recently, we reported on the processing and microstructural study of nanostructured 10 mol% CeO₂-ZrO₂ 68 ceramics prepared by spark plasma sintering (SPS) [17]. 69 This technique has emerged as a powerful tool in ceramics 70 processing, as it allows fast densification of ceramics at relatively low temperatures and pressures by the simulta-72 neous application of pressure and a low DC voltage to the 73 graphite mold during heating [18–20]. We have shown that 74 the highly reducing atmosphere created by the graphite 75 environment during SPS promoted the gradual reduction of 76 Ce^{4+} to Ce^{3+} , giving place to presence of pyrochlore phase 77 when sintering at 1200 °C for 5 min. Several authors have shown that the reduction of metastable tetragonal phase, denoted as t' phase, at temperatures ≥ 1050 °C leads to 80 pyrochlore phases (Ce₂Zr₂O_{7+ δ}) [12, 14, 21–23]; however, to the best of our knowledge, no studies have been pub-82 lished on the appearance of these phases in spark plasma 83 sintered CeO₂–ZrO₂ ceramics with different CeO₂ doping concentrations and the effect of phase formation on the 85 conductivity in this system.

86 In this study, 10, 16 and 33 mol% CeO₂-doped ZrO₂ 87 powders were obtained by means of a two-step synthesis 88 route and subsequently sintered by SPS. Phase assembly of 89 the ceramics was analyzed by X-ray diffraction and Riet-90 veld refinement. The effect of the CeO₂ content on the 91 phase assembly of the ceramics was investigated. The 92 electrical conductivity as a function of temperature 93 (200–900 °C) was analyzed in three different atmospheres. 94 The structural characterization was of prime relevance for 95 understanding the electrical conductivity results as the 96 different conduction mechanisms found were related to the 97 phase assembly of the ceramics.

98 **Experimental procedure**

Powder synthesis and characterization 99

100 According to the phase diagram for the system Ce₂O₃-101 ZrO_2 [24], the compound $Ce_2Zr_2O_7$ with pyrochlore 102 structure is in equilibrium with monoclinic/tetragonal 103 phases above and below 1000 °C, respectively, for com-104 positions with Zr/Ce atomic ratios between 1.3 (44 mol% 105 Ce_2O_3) and 32.3 (3 mol% Ce_2O_3). Thus, the formation of 106 the pyrochlore cubic structure stabilizes the ZrO₂ tetrago-107 nal phase, promoting an increase of ionic conductivity by increase of the oxygen vacancies, as a consequence of the 108 substitution of Ce^{3+} for Zr^{4+} . Using this phase diagram, 109 110 the CeO₂ compositions (10, 16 and 33 mol% CeO₂) were 144

selected among those that stabilize the tetragonal phase by 111 112 the formation of pyrochlore phase.

Ce_{0.10}Zr_{0.90}O₂ (CeZr10), Ce_{0.16}Zr_{0.84}O₂ (CeZr16) and 113 $Ce_{0.33}Zr_{0.67}O_2$ (CeZr33) mixed oxides were synthesized by 114 a two-step synthesis procedure. In a first step, a hydro-115 116 thermal route was followed to synthesize nanocrystalline ZrO_2 powder. Zirconvl nitrate hydrate ($ZrO(NO_3) \cdot xH_2O$, 117 0.5 M, <90 % purity) and sodium hydroxide (NaOH, 5 M) 118 were mixed together and sonicated for 30 min. Later, 119 120 10 mL of the solution was disposed in the hydrothermal 121 vessel with 2 mL of ethanol, closed and heated in a furnace for 5 h at 200 °C. When the vessel achieved room tem-122 perature, the solid was washed with distilled water and 123 dried at 100 °C for 1 h. In a second step, cerium oxide was 124 deposited onto the ZrO₂ particles by the impregnation 125 method. The adequate amount of 1 M Ce(NO)₃·6H₂O 126 solution (99.5 % purity) was added to the solid in order to 127 obtain 10, 16 or 33 mol% CeO₂-ZrO₂ powders. The 128 resulting slurries were then dried for 12 h at 100 °C. 129 Finally, the ceramic powders were calcined at 700 °C for 130 4 h. The powders were suspended in aqueous solution and 131 subjected to ultrasonic agitation in order to reduce 132 agglomeration before their analysis. 133

X-ray diffraction (PANalytical X'Pert Pro diffractome-134 ter) was used for phase identification of the powders. 135 Diffraction patterns were recorded using Cu Ka radiation 136 over a 2θ range of 10° -90° and a position-sensitive 137 detector using a step size of $0.05^{\circ}2\theta$ and a counting time of 138 1 s per step. 139

The cerium and zirconium contents of the samples were 140 141 determined by X-ray fluorescence spectrometry (XRF-Panalytical AXIOS PW4400) sequential spectrophotometer 142 with a rhodium tube as the source of radiation. 143

Ceramics processing and characterization

SPS (Model 515S, SPS Dr Sinter Inc., Kanagawa, Japan) of 145 the ceramic powders was performed in a vacuum in a 146 15-mm-diameter cylindrical graphite die/punch setup, 147 under a uniaxial pressure of 50 MPa at 1200 °C for 5 min 148 or without holding time. The heating rate was 100 °C/min. 149 The applied pressure was maintained throughout the entire 150 thermal cycle. Hereinafter, we will refer to the sintered 151 samples as CeZr10-0 min, CeZr10-5 min, CeZr16-0 min 152 and CeZr33-0 min. Temperature was measured by using a 153 154 thermocouple, which was placed in a bore hole in the middle part of the graphite die. The sintered ceramics of 155 approximately 15 mm \times 2 mm were polished in order to 156 eliminate the surface carbon. Density of the ceramics was 157 determined using the Archimedes method, using water as 158 the immersion liquid. Theoretical density for each com-159 position was calculated according to: 160

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 $\begin{array}{l} \mbox{Theoretical density} = (\mbox{density } (\mbox{CeO}_2)) * \ \mbox{wt\%}(\mbox{CeO}_2) \\ + (\mbox{density } (\mbox{ZrO}_2)) * \ \mbox{wt\%}(\mbox{ZrO}_2). \end{array}$

162 In order to approach phase identification and structural 163 characterization, powder diffraction patterns were collected 164 on the polished, cross-section surfaces of the ceramics. The 165 step scan technique was used with a step size of $0.02^{\circ}2\theta$ 166 and a counting time of 10 s at each point.

167 Rietveld refinements were performed using the FULL-168 PROF software [25]. In this method, a least-squares 169 refinement of a crystallographic model is performed until a satisfactory fit is achieved between the theoretical dif-170 171 fractogram and the experimental data. A pseudo-Voigt 172 function was chosen to describe the peak shape, and the 173 refinement included the following parameters: (1) the 174 background, generated by linear interpolation of a set of 175 background points with refinable heights; (2) the scale 176 factors; (3) the global instrumental parameters (zero-point 177 2θ shift and systematic shifts, depending on transparency 178 and off-centering of the sample); (4) the lattice parameters 179 for all phases; (5) the profile parameters (Caglioti half-180 width parameters and the mixing parameter, η , of the 181 pseudo-Voigt function) [26]; (6) refinable atom coordi-182 nates; and (7) occupancy factors for all atomic species.

183 Quantitative phase analysis with the Rietveld method184 relies on the simple relationship:

$$W_i = S_i(ZMV) / \sum_{i=1}^n S_j(ZMV)$$

186 where W_i is the relative weight fraction of the phase *i* in a 187 mixture of *n* phases, and *S*, *Z*, *M* and *V* are, respectively, 188 the Rietveld scale factor, the number of formula units per 189 cell, the mass of the formula unit and the unit cell volume. 190 Among the profile parameters, it can be outlined the full 191 width at half maximum (FWHM), which is usually 192 expressed as a quadratic form in $tan\theta$, as introduced by 193 Caglioti et al. [27]:

$$(FWHM)^2 = U \tan^2 \theta + V \tan \theta + W$$

195 depending on the U, V and W refinable parameters.

Taking into account that many materials have nonstoichiometry deviations and different kinds of disorder, the refinement of site occupancy is required. The site occupancy factors (*f*) can be defined as the fraction of atoms in a particular Wyckoff position in such a way that f = 1 indicates full occupancy.

The quality of the Rietveld refinement is quantified by several figures of merit [28]: profile residual, $R_{\rm p}$, weighted profile residual, $R_{\rm wp}$, expected residual, $R_{\rm exp}$, and Bragg residual $R_{\rm B}$. In any case, none of these residuals is a substitute for the plots of the observed and calculated patterns, supplemented by the differences plotted on the same scale.



Fig. 1 XRD patterns of the calcined CeO₂–ZrO₂ powders with 16 mol% CeO₂ (a) and 33 mol% CeO₂ (b)

Microstructural investigation was performed by scanning electron microscopy (Hitachi S4800 SEM-FEG). 209

Electrical properties were measured by impedance 210 spectroscopy with an Agilent 4294A equipment; two-point 211 measurements were performed on the samples sandwiched 212 between Pt foils that acted as electrodes and that contacted 213 the sample through simple mechanical pressure. Pt paste 214 electrodes were not applied to the samples before testing, 215 since microstructural changes could be induced during 216 electrode firing. The samples were placed in a tubular 217 furnace where atmosphere and temperature were con-218 trolled. Measurements were acquired in N2, H2 and O2 219 atmosphere, and oxygen partial pressure was not recorded 220 while measuring, in the frequency range from 40 to 10^7 Hz 221 and varying the temperature from 200 to 900 °C. The 222 conductivity values were determined after fitting the 223 spectra with the Zview software. 224

Results and discussion

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The XRD patterns for the calcined CeZr16 and CeZr33 226 powders are presented in Fig. 1. It has been published [17] 227 that the presence of monoclinic ZrO₂ phase (JCPDS 228 229 01-078-0047) in the starting powder is clear. However, when increasing the CeO_2 content to 10 mol%, other 230 phases are found [17]. In the powders with 16 mol% CeO₂, 231 the tetragonal solid solution (JCPDS 01-080-0) is present, 232 and the $Ce_{0.40}Zr_{0.40}O_2$ solid solution is found in the pow-233 ders with 16 and 33 mol% CeO_2 . Also, a decrease in the 234 peaks corresponding to the monoclinic ZrO2 phase is 235 observed in the two powders with higher CeO₂ content. 236 The observed phases are in agreement with the phase 237

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Fig. 2 SEM micrographs of a the calcined 16 mol% $CeO_2\text{--}ZrO_2$ powder and b the calcined 33 mol% $CeO_2\text{--}ZrO_2$ powder

 Table 1 Density, relative density and grain size of the ceramics

Ceramic	Theoretical	Measured	Relative density (%)	Grain size (nm)	
	(g/cm ³)	density (g/cm ³)		Core region	Edge region
CeZr16- 0 min	5.97	5.85	98.0	50–70	50–70
CeZr33- 0 min	6.13	5.60	91.4	40–70	100–150

diagram reported by Kaspar et al. [29] for CeO₂–ZrO₂ solid
solution. The same crystallite size (20 nm) was obtained
for all compositions.

The cerium and zirconium contents of the powders, determined by XRF, are identical as the nominal ones. SEM micrographs of the calcined CeZr16 and CeZr33 powders show a spherical shape and a grain size lower than 100 nm in both of them (Fig. 2). Similar characteristics have been published for the calcined CeZr10 powder [17].

Table 1 shows density and relative density of the sintered ceramics. Nearly full densification (>98 % TD) was obtained in the CeZr16-0 min ceramic, similar to the reported result for the CeZr10-0 min and CeZr10-5 min ceramics [17], whereas a lower relative density, 91.4 %, was measured in the ceramic with higher CeO₂ content. No micro- or macrocracks were observed in the ceramics, conversely to the results published by Huang et al. [30] for254similar materials. These authors reported the existence of255macrocracks in 12 mol% CeO2-doped ZrO2 ceramics pre-256pared by SPS and related this fact to the presence of a large257amount of monoclinic ZrO2 phase.258

259 Using the experimental X-ray diffraction patterns, Rietveld refinements were carried out in CeZr16-0 min and 260 CeZr33-0 min ceramics. In a first analysis of the CeZr16-261 0 min ceramic, four phases were discerned, tetragonal, 262 monoclinic, cubic pyrochlore and some residual graphite, 263 this latter most likely being a rest of the graphite foil used 264 during SPS that was not suitably removed. In an earlier 265 study [17], we have shown that the highly reducing 266 atmosphere created by the graphite environment during 267 SPS promotes the reduction of Ce^{4+} to Ce^{3+} in CeO_2 -ZrO₂ 268 ceramics, and the obtained phases are in agreement with 269 the ZrO_2 -Ce₂O₃ phase diagram [24]. 270

However, during the analysis of the Rietveld refinement 271 of the CeZr16-0 min ceramic, we noted that the pyrochlore 272 amount [54.1(7) wt%] was quite high given the Ce avail-273 274 able in the system (16 mol%). Moreover, when refining the 275 occupancy factors, it was found that almost all the Ce is present in the pyrochlore phase, and a composition of 276 277 $Zr_{3,26}Ce_{0,74}O_{7,63}$ was obtained, which implies that in this phase Ce and Zr are not in 1:1 stoichiometry. Besides that, 278 the reliability factors (i.e., $\chi^2 = 5.60$) are not fully satis-279 factory, a fact that is particularly true for the $R_{\rm B}$ and $R_{\rm F}$ 280 281 residuals associated with the cubic pyrochlore phase. This disagreement, together with the anomalous stoichiometry 282 of this phase, far from the usual formula $A_2B_2O_7$ of the 283 pyrochlore oxides, led us to evaluate an alternative model 284 for the pyrochlore structure. 285

In fact, other authors have reported for some particular 286 pyrochlore systems alternative groups of symmetry to the 287 usual cubic $Fd\overline{3}m$. Taking into account the maximal sub-288 groups of the $Fd\overline{3}m$, Thomson et al. [31] proposed the 289 rhombohedral $R\overline{3}m$ group of symmetry for Ce₂Zr₂O_{7.97}, 290 whereas Sasaki et al. [32] found the cubic phase $F\overline{4}3m$ for 291 292 the composition Ce₂Zr₂O_{7.5}. Kishimoto et al. [33] found the P2₁3 group of symmetry for the Ce₂Zr₂O₈ composition 293 (also called κ -CeZrO₄ phase), although this last group is 294 not a subgroup of the original $Fd\overline{3}m$. In a first stage, we 295 tested these structures for our pyrochlore phase, but the 296 Rietveld refinement worsened in relation to our first con-297 ventional refinement. In the same way, we have investi-298 gated, with negative results, the possibility of the δ -phase, 299 300 reported by Thornber et al. [34]: a fluorite-related structure with different stoichiometries for both kinds of cations. 301

By considering that according to Wuensch et al. [35], 302 pyrochlore is the only oxide in which simultaneous orderdisorder transformations take place for both the anion and cation arrays in structure, we proposed a new model with 305

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Fig. 3 Rietveld refined powder XRD data for **a** the CeZr16-0 min ceramic and **b** the CeZr33-0 min ceramic

306 the tetragonal I41/amd symmetry. In fact, this is the only 307 maximal subgroup of the $Fd\overline{3}m$ group in the tetragonal 308 system. Transformations of order for cation, anion or both 309 arrays could justify this reduction in symmetry. For this 310 new Rietveld refinement, cation occupancies were freely 311 refined in both 8c and 8d sites, with the only constraint of 312 full occupancy at each site. This can be justified as long as 313 the XRD pattern is largely dominated by the scattering of 314 the heavy cations. For this reason, the same accuracy is not 315 possible for oxygen atoms, for which we allowed the possibility of partial occupancy and vacancies in 16g, 8e, 316 317 4a and 4b sites but maintained the constraint of global 318 charge balance. The starting lattice parameters were 319 obtained with the indexing software TREOR [36] applied 320 to the first 20 observed pyrochlore reflections. A promising 321 de Wolff [37] figure of merit M(20) = 88 was obtained.

322 Plot of the Rietveld refinement corresponding to the 323 CeZr16-0 min sintered ceramic is given in Fig. 3a. The 324 main results of the Rietveld analysis are shown in Table 2. 325 The major crystalline phase is the Ce-deficient tetragonal 326 pyrochlore [50.0(4) wt%], with an axial ratio 327 $c/a\sqrt{2} = 0.989$, highlighting the pseudocubic character of 328 that tetragonal phase of composition Zr_{3,21}Ce_{0,78}O_{7,59}. 329 Contributions of tetragonal [31.6(2) wt%] and monoclinic

Table 2 Rietveld refinement of the CeZr16-0 min ceramic

Phase	Tetragonal pyrochlore	Tetragonal	Monoclinic	Graphite
Fraction (wt%)	50.0 (4)	31.6 (2)	13.4 (4)	4.9 (2)
a (Å)	7.489 (8)	3.6051 (7)	5.276 (3)	2.413 (3)
b (Å)	7.489 (8)	3.6051 (7)	5.259 (3)	2.413 (3)
c (Å)	10.477 (1)	5.197 (1)	5.165 (3)	6.707 (2)
β	_	-	98.69 (3)	_
Group of symmetry	I4 ₁ /amd	P4 ₂ /nmc	P21/c	P6 ₃ / mmc
R _{wp}	4.78			
R _{exp}	2.18			
χ^2	4.83			

 Table 3 Reliability parameters of the cubic and tetragonal models for the pyrochlore structure

	Cubic pyrochlore	Tetragonal pyrochlore
R _{wp}	5.60	4.78
R _{exp}	2.18	2.18
χ^2	6.6	4.83
R _B	3.7	1.50
R _F	1.97	1.01

T	al	ole	4	R	lietveld	refinement	of	the	CeZr33-0	min	ceramic
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Phase	Tetragonal Pyrochlore	Tetragonal
Fraction (wt%)	81.61 (9)	18.4 (6)
a = b (Å)	7.5115 (9)	3.6100 (6)
c (Å)	10.574 (2)	5.202 (1)
Group of symmetry	I41/amd	P4 ₂ /nmc
R _{wp}	7.32	
R _{exp}	3.67	
χ^2	3.99	

[13.4(4) wt%] phases and a trace of residual graphite 330 [4.9(2) wt%] were also present in the refinement. 331

In Table 3, we report the comparison between the reliability parameters for both models, cubic and tetragonal. The reported results support the superiority of our tetragonal model. To the best of our knowledge, this is the first time that a tetragonal pyrochlore has been reported in the literature for this system. Additional crystallographic data for this new structure will be reported elsewhere. 332

The Rietveld analysis for the CeZr33-0 min ceramic 339 was also modeled taking into account the tetragonal variant 340 of the pyrochlore structure just introduced, and the 341

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Fig. 4 SEM micrographs of the surface (a) and core (b) area of the CeZr16-0 min ceramic and the surface (c) and core (d) area of the CeZr33-0 min ceramic



342 refinement indicated the formation of only two phases 343 (Table 4). The major crystalline phase is the Ce-deficient 344 tetragonal pyrochlore structure [81.6(9) wt%] and the 345 minor phase the tetragonal one [18.4(6) wt%]. Plot of the 346 Rietveld refinement corresponding to the CeZr33-0 min sintered ceramic is given in Fig. 3b. In this case, the 347 348 refinement of the occupancy factors led to a composition 349 $Zr_{2,8}Ce_{1,2}O_{7,4}$ for the pyrochlore structure, and an axial ratio $c/a\sqrt{2} = 0.995$, also pseudocubic but more distorted 350 351 as compared to the previous ceramic.

352 The described phase assemblies are quite different than 353 the reported ones for the 10 mol% CeO₂-ZrO₂ ceramics 354 sintered for 5 min and without holding time [17]. In these 355 cases, whereas in the latter the major crystalline phase is 356 metastable tetragonal, t' (90.9 wt%), and the minor phase is 357 tetragonal (9.1 wt%), in the former the phases were 358 tetragonal (82.5 wt%), monoclinic (15.1 wt%) and py-359 rochlore (2.4 wt%). We showed [17] that the obtained 360 phases are consequence of the highly reducing atmosphere 361 created by the graphite environment during SPS, which promotes the reduction of Ce^{4+} ions to Ce^{3+} . However, the 362 363 pyrochlore phase was found only when the sintering tem-364 perature was held for 5 min. On the contrary, when the CeO₂ amount increases to 16 and 33 mol%, even when 365 sintering without holding time the tetragonal phase is 366 367 destabilized and great amounts of pyrochlore phase are 368 present in both ceramics. Also, we have found that the cubic pyrochlore phase declined into tetragonal pyrochlore. 369 The reduction of Ce^{4+} ions to Ce^{3+} in the CeZr33-0 min 370

ceramic promotes also the presence of some porosity in this ceramic (Table 1), as a consequence of oxygen loss. 372

The SEM micrographs of the CeZr16-0 min and 373 CeZr33-0 min ceramics are shown in Fig. 4. Fracture 374 375 surface was analyzed in order to avoid possible oxidation during polishing and etching. A homogeneous micro-376 structure with a grain size about 50-70 nm in the whole 377 ceramic is observed in the CeZr16-0 min ceramic. This 378 microstructure is similar to the reported one for the 379 CeZr10-0 min ceramic [17]. Conversely, a graded micro-380 structure with 100-150 nm grain size in the edge region 381 and 40-70 nm grain size in the core region is observed in 382 the CeZr33-0 min ceramic (Table 1). Graded microstruc-383 tures have been previously reported for samples similar to 384 the ones under study [27]. During SPS, the edge has much 385 lower oxygen partial pressure, which could lead to a gra-386 dient of Ce^{4+} reduction to Ce^{3+} from outside to inside. 387 Whereas for the CeZr16-0 min ceramic it is thought that 388 most of the Ce⁴⁺ has converted to Ce³⁺ according to the 389 homogeneous microstructure, for the CeZr33-0 min it 390 looks like the reduction beneath the edge area was not as 391 392 fast and complete as that of the edge area, giving rise to the 393 graded microstructure.

Nyquist plots measured on the CeZr10-0 min and
CeZr33-0 min ceramics at 600 °C are shown in Fig. 5.394These compositions have been selected on the basis of their
Ce content. The spectra obtained have been fitted to an
equivalent circuit composed by two RQs (constant phase
element in parallel with a resistance) connected in series394

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Fig. 5 Nyquist plots of the **a** CeZr10-0 min and **b** CeZr33-0 min ceramics, measured in N_2 , H_2 and O_2 atmospheres at 600 °C



Fig. 6 Electrical conductivity versus temperature measured in the sintered ceramics in nitrogen atmosphere

400 (inset in Fig. 5a). The first one has been ascribed to the
401 material, while the second one is related to the interface
402 between the electrode and the ceramic sample. On this
403 sense, the conductivity has been calculated from intercept



Fig. 7 Electrical conductivity versus temperature measured in the sintered ceramics in hydrogen atmosphere



Fig. 8 Electrical conductivity versus temperature measured in the sintered ceramics in oxygen atmosphere

of the first semicircle with the real part of impedance. This404value represents the total conductivity of the material,405while the arc corresponding to the ceramic–electrode406interface was not analyzed in this work.407

Figures 6, 7 and 8 show the Arrhenius plots for all the408studied ceramics measured in N_2 , H_2 and O_2 atmosphere,409respectively. The slope of these diagrams has been used to410calculate the activation energy of the conducting species411(Table 5).412

It is clear that the Arrhenius plots are highly dependent 413 on the ceramic phase assembly. In the CeZr10-0 min 414 ceramic (metastable t' phase: 91 wt%, tetragonal phase: 415 9 wt% [17]), single activation energies were evidenced for 416 the whole temperature range in the three different atmo-417 spheres, pointing out to the existence of only one con-418 duction mechanism. A value close to 0.85 eV was obtained 419 in the three cases, very similar to the reported one by 420 previous authors [5, 6, 8] for ceramics with similar 421

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Table 5 Phase assembly andelectrical properties of thesintered ceramics

Ceramic	Phases from Rietveld	E_a (eV)			
	refinement (wt%)	N ₂ atmosphere	H ₂ atmosphere		O ₂
			200–500 °C	500–900 °C	atmosphere
CeZr10-0 min	t' 90.9 %, t 9.1 %	0.85	0.90		0.90
CeZr10-5 min	t 82.5 %, m 15.1 %, p 2.4 %	0.68	0.78	0.60	0.92
CeZr16-0 min	t 31.6 %, m 13.4 %, p 50.0 %	0.58	0.70	0.20	-
CeZr33-0 min	t 18.4 %, p 81.6 %	0.58	0.49	0.18	0.93

422 composition and phases, and equilibrium defect concen-423 trations. This result is consistent with the activation energy 424 for oxygen vacancy conduction in zirconia-based ceramic 425 oxides [5, 6], where the electronic contribution to the total 426 conductivity is not significant comparing with the ionic. 427 The lower value of conductivity was registered when 428 measuring in the O_2 atmosphere. This is consequence of the re-oxidation of the Ce^{3+} ions to Ce^{4+} , which eliminates 429 430 the electronic conductivity of the samples.

431 In the CeZr10-5 min, CeZr16-0 min and CeZr33-0 min 432 ceramics, with more complex phase assemblies, different 433 behavior was obtained as a function of the present phases 434 and also as a function of the measuring atmosphere. Dif-435 ferences were observed in the activation energies as a 436 function of the amount of pyrochlore phase in these 437 ceramics, when the conductivity was measured in N2 438 (Table 5). In the two ceramics showing a high amount of 439 pyrochlore, activation energy of 0.58 eV was obtained. 440 This value is very similar to the reported one by Baidya 441 et al. [14] for the $Ce_2Zr_2O_7$ phase, which is shown to be an 442 n-type semiconductor in the temperature range 400-850 K. 443 Thus, we can conclude that the pyrochlore phase is con-444 trolling the conducting behavior in these two ceramics. In 445 the CeZr10-5 min ceramic, with only a 2.40 wt% pyroch-446 lore phase, an activation energy of 0.68 eV was found, 447 which is an intermediate value between the corresponding 448 one for oxygen vacancy conduction (0.85 eV) and the 449 corresponding one for n-type conduction (0.5 eV). In this 450 ceramic, the low percentage of pyrochlore can significantly 451 modify the conducting behavior of the material.

452 It is noticeable that whereas the Arrhenius plots obtained 453 in N_2 and O_2 were straight lines, a slope change was 454 noticed around 500 °C when measuring the conductivity in 455 H₂ atmosphere. In the CeZr10-5 min ceramic, the activa-456 tion energy decreases from 0.78 to 0.60 eV. In the CeZr16-457 0 min and CeZr33-0 min ceramics, the observed decrease 458 in activation energy is more significant, with values of 459 0.18–0.20 eV in the high temperature range (500–900 °C). 460 The changes in the Arrhenius plots slope have been usu-461 ally related to changes in physical or chemical structure or to 462 the existence of two conduction mechanisms [5, 6].

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Temperature programmed reduction (TPR) studies carried 463 out by different authors in the CeO₂–ZrO₂ system [14, 23] 464 have shown the existence of two peaks around 450-550 and 465 700-800 °C on the hydrogen uptake for $Ce_{r}Zr_{1-r}O_{2}$ reduc-466 tion. The oxygen stoichiometries estimated from the quantity 467 of hydrogen uptake showed that the first step reduction 468 corresponds to $Ce_2Zr_2O_7$ (pyrochlore I) and the second step 469 470 reduction corresponds to $Ce_2Zr_2O_{6,2}$ (pyrochlore II) [14].

Taking these reports into account, the decrease in slope 471 in the high temperature range described above may be 472 clarified. In the ceramic with initially only 2.40 wt% py-473 474 rochlore phase, a higher degree of reduction could be achieved during the conductivity measurement in H₂ 475 atmosphere, which resulted in a structural change into a 476 477 higher amount of pyrochlore. Thus, an activation energy corresponding to n-type conduction was obtained in this 478 479 ceramic. In the CeZr16-0 min and CeZr33-0 min ceramics, the pyrochlore amounts were initially 50.0 and 81.6 wt%, 480 respectively. Thus, during the conductivity measurement in 481 482 the highly reducing atmosphere, the pyrochlore I could be strongly reduced into Ce₂Zr₂O_{6,2}. This phase has been 483 shown to have a significantly low resistivity, which 484 remains constant in the 400-1000 K range [14]. Activation 485 energy of 0.08 eV was reported for lower temperatures. 486 Thus, the low activation energies found in the CeZr16-487 0 min and CeZr33-0 min ceramics are clearly related to the 488 489 presence of Ce₂Zr₂O_{6.2} phase.

Regarding the conductivity values, higher values were490obtained in the CeZr16-0 min and CeZr33-0 min ceramics491in the whole range of temperature, when measuring in N_2 492and H_2 atmosphere. This is clearly related to the presence493of pyrochlore in the ceramics.494

495 When characterizing the ceramics in O_2 atmosphere, very similar Arrhenius plots were found in all of them. 496 Activation energy ~ 0.9 eV was found in all the ceramics; 497 thus, the electrical conductivity shows the typical ionic 498 conduction behavior, and the oxygen anti-Frenkel defects 499 are the predominant defects. It is clear that the re-oxidation 500 of the ceramics promoted a decrease in the concentration of 501 oxygen vacancies, as the lower conductivity values were 502 obtained when measuring in O₂ atmosphere. 503

504 Conclusions

505 Spark plasma sintering of $Ce_x Zr_{1-x}O_2$ (x = 0.10, 0.16 and 506 0.33) powders obtained by a two-step synthesis technique 507 resulted in ceramics with different phase assemblies, as a 508 consequence of the reduction of Ce^{4+} to Ce^{3} in the highly reducing atmosphere created by the graphite environment 509 510 during the sintering process. Phase identification carried 511 out by means of Rietveld refinements showed the presence of a Ce-deficient tetragonal pyrochlore as the major phase 512 513 in the ceramics with higher CeO₂ content, with tetragonal 514 and monoclinic as minor phases.

515 The electrical conductivity of the ceramics was highly 516 dependent on the phase assembly, and higher conductivity 517 values were obtained in the ceramics with higher pyroch-518 lore content, when measuring in N₂ and H₂ atmosphere. 519 Whereas the ceramics with tetragonal phase showed an 520 ionic conduction by oxygen vacancies independent of the 521 atmosphere, a significant effect of the measuring atmo-522 sphere was observed in the ceramics with pyrochlore 523 phase. A n-type semiconducting behavior seems to manage 524 the conduction mechanism in the latter when measuring in 525 N₂. However, a significant decrease in the activation energy was noticed around 500 °C when measuring the 526 527 conductivity in H₂ atmosphere, consequence of the strong 528 reduction promoted in these ceramics during the mea-529 surement. However, similar activation energies were 530 observed for all compositions measured in O2, which cor-531 responds to ionic conduction behavior reported in the 532 literature.

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